



# BUK9K52-60RA

Dual N-channel 60 V, 55 mOhm logic level MOSFET in LFAK56D using Repetitive Avalanche technology

2 December 2020

Product data sheet

## 1. General description

Dual, logic level N-channel MOSFET in an LFAK56D package, using Application Specific (ASFET) repetitive avalanche silicon technology. This product has been designed and qualified to AEC-Q101 for use in repetitive avalanche applications.

## 2. Features and benefits

- Fully automotive qualified to AEC-Q101 at 175 °C
- Repetitive Avalanche rated to 30 °C  $T_j$  rise:
  - Tested to 1 Bn avalanche events
- LFAK copper clip package technology:
  - High robustness and reliability
  - Gull wing leads for high manufacturability and AOI

## 3. Applications

- 12 V, 24 V and 48 V automotive systems
- Repetitive avalanche topologies
- Engine control
- Transmission control
- Actuator and auxiliary loads

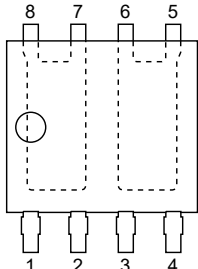
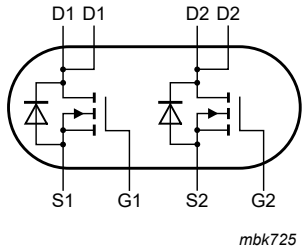
## 4. Quick reference data

Table 1. Quick reference data

| Symbol                                       | Parameter                        | Conditions                                                                                                                                     | Min  | Typ  | Max | Unit |
|----------------------------------------------|----------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----|------|
| $V_{DS}$                                     | drain-source voltage             | $25\text{ °C} \leq T_j \leq 175\text{ °C}$                                                                                                     | -    | -    | 60  | V    |
| $I_D$                                        | drain current                    | $V_{GS} = 5\text{ V}$ ; $T_{mb} = 25\text{ °C}$ ; <a href="#">Fig. 2</a>                                                                       | -    | -    | 16  | A    |
| $P_{tot}$                                    | total power dissipation          | $T_{mb} = 25\text{ °C}$ ; <a href="#">Fig. 1</a>                                                                                               | -    | -    | 32  | W    |
| <b>Static characteristics FET1 and FET2</b>  |                                  |                                                                                                                                                |      |      |     |      |
| $R_{DSon}$                                   | drain-source on-state resistance | $V_{GS} = 5\text{ V}$ ; $I_D = 5\text{ A}$ ; $T_j = 25\text{ °C}$ ; <a href="#">Fig. 15</a>                                                    | 26.7 | 47.3 | 55  | mΩ   |
| <b>Dynamic characteristics FET1 and FET2</b> |                                  |                                                                                                                                                |      |      |     |      |
| $Q_{GD}$                                     | gate-drain charge                | $I_D = 5\text{ A}$ ; $V_{DS} = 48\text{ V}$ ; $V_{GS} = 5\text{ V}$ ; $T_j = 25\text{ °C}$ ; <a href="#">Fig. 17</a> ; <a href="#">Fig. 18</a> | -    | 2.3  | -   | nC   |

## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline                                                                                                     | Graphic symbol                                                                                    |
|-----|--------|-------------|------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------|
| 1   | S1     | source1     |  <p>LFPAK56D; Dual LPAK (SOT1205)</p> |  <p>mbk725</p> |
| 2   | G1     | gate1       |                                                                                                                        |                                                                                                   |
| 3   | S2     | source2     |                                                                                                                        |                                                                                                   |
| 4   | G2     | gate2       |                                                                                                                        |                                                                                                   |
| 5   | D2     | drain2      |                                                                                                                        |                                                                                                   |
| 6   | D2     | drain2      |                                                                                                                        |                                                                                                   |
| 7   | D1     | drain1      |                                                                                                                        |                                                                                                   |
| 8   | D1     | drain1      |                                                                                                                        |                                                                                                   |

## 6. Ordering information

Table 3. Ordering information

| Type number  | Package                |                                                                   |         |
|--------------|------------------------|-------------------------------------------------------------------|---------|
|              | Name                   | Description                                                       | Version |
| BUK9K52-60RA | LFPAK56D;<br>Dual LPAK | plastic, single ended surface mounted package (LFPAK56D); 8 leads | SOT1205 |

## 7. Marking

Table 4. Marking codes

| Type number  | Marking code |
|--------------|--------------|
| BUK9K52-60RA | 95260RA      |

## 8. Limiting values

Table 5. Limiting values

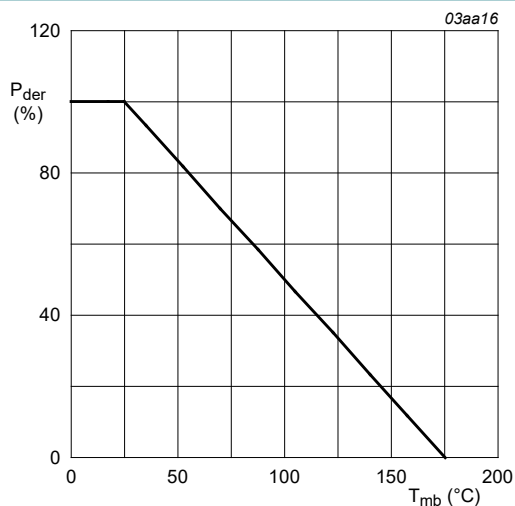
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol       | Parameter                  | Conditions                                                                                            | Min         | Max | Unit               |
|--------------|----------------------------|-------------------------------------------------------------------------------------------------------|-------------|-----|--------------------|
| $V_{DS}$     | drain-source voltage       | $25\text{ }^{\circ}\text{C} \leq T_j \leq 175\text{ }^{\circ}\text{C}$                                | -           | 60  | V                  |
| $V_{DGR}$    | drain-gate voltage         | $25\text{ }^{\circ}\text{C} \leq T_j \leq 175\text{ }^{\circ}\text{C}$ ; $R_{GS} = 20\text{ k}\Omega$ | -           | 60  | V                  |
| $V_{GS}$     | gate-source voltage        | DC; $T_j \leq 175\text{ }^{\circ}\text{C}$                                                            | -10         | 10  | V                  |
|              |                            | Pulsed; $T_j \leq 175\text{ }^{\circ}\text{C}$                                                        | [1] [2] -15 | 15  | V                  |
| $P_{tot}$    | total power dissipation    | $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; Fig. 1                                                        | -           | 32  | W                  |
| $I_D$        | drain current              | $V_{GS} = 5\text{ V}$ ; $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; Fig. 2                                | -           | 16  | A                  |
|              |                            | $V_{GS} = 5\text{ V}$ ; $T_{mb} = 100\text{ }^{\circ}\text{C}$ ; Fig. 2                               | -           | 11  | A                  |
| $I_{DM}$     | peak drain current         | pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; $T_{mb} = 25\text{ }^{\circ}\text{C}$ ; Fig. 3             | -           | 64  | A                  |
| $T_{stg}$    | storage temperature        |                                                                                                       | -55         | 175 | $^{\circ}\text{C}$ |
| $T_j$        | junction temperature       |                                                                                                       | -55         | 175 | $^{\circ}\text{C}$ |
| $T_{sld(M)}$ | peak soldering temperature |                                                                                                       | -           | 260 | $^{\circ}\text{C}$ |

## Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

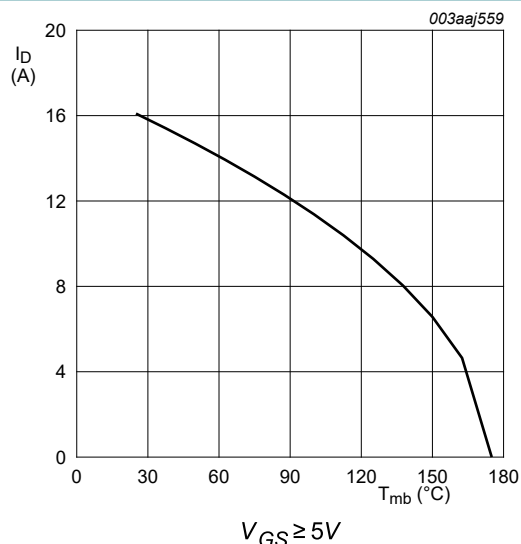
| Symbol                                    | Parameter                                    | Conditions                                                                                                                                                                     |             | Min | Max  | Unit |
|-------------------------------------------|----------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------|-----|------|------|
| <b>Source-drain diode FET1 and FET2</b>   |                                              |                                                                                                                                                                                |             |     |      |      |
| $I_S$                                     | source current                               | $T_{mb} = 25\text{ °C}$                                                                                                                                                        |             | -   | 16   | A    |
| $I_{SM}$                                  | peak source current                          | pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; $T_{mb} = 25\text{ °C}$                                                                                                             |             | -   | 64   | A    |
| <b>Avalanche ruggedness</b>               |                                              |                                                                                                                                                                                |             |     |      |      |
| $E_{DS(AL)R}$                             | repetitive drain-source avalanche energy     | $I_D = 0.5\text{ A}$ ; $V_{sup} \leq 60\text{ V}$ ; $R_{GS} = 10\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; $T_{j(rise)} \leq 30\text{ °C}$ ; unclamped; Fig. 4; Fig. 5; Fig. 6 | [3] [4] [5] | -   | 19.5 | mJ   |
| <b>Avalanche ruggedness FET1 and FET2</b> |                                              |                                                                                                                                                                                |             |     |      |      |
| $E_{DS(AL)S}$                             | non-repetitive drain-source avalanche energy | $I_D = 16\text{ A}$ ; $V_{sup} \leq 60\text{ V}$ ; $V_{GS} = 5\text{ V}$ ; $T_{j(init)} = 25\text{ °C}$ ; Fig. 7                                                               | [6] [7]     | -   | 11.9 | mJ   |

- [1] Accumulated Pulse duration up to 50 hours delivers zero defect ppm  
 [2] Significantly longer life times are achieved by lowering  $T_j$  and or  $V_{GS}$   
 [3] Repetitive avalanche rating is limited by maximum junction temperature of 175 °C and junction rise of 30 °C  
 [4] Refer to Fig. 5 for the limiting number of avalanche events  
 [5] Refer to Fig. 6  $R_{dson}$  at  $V_{GS}=5V$  will increase as a function of repetitive avalanche cycles  
 [6] Refer to application note AN10273 for further information  
 [7] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ\text{C})}} \times 100\%$$

**Fig. 1. Normalized total power dissipation as a function of mounting base temperature**



**Fig. 2. Continuous drain current as a function of mounting base temperature**

Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

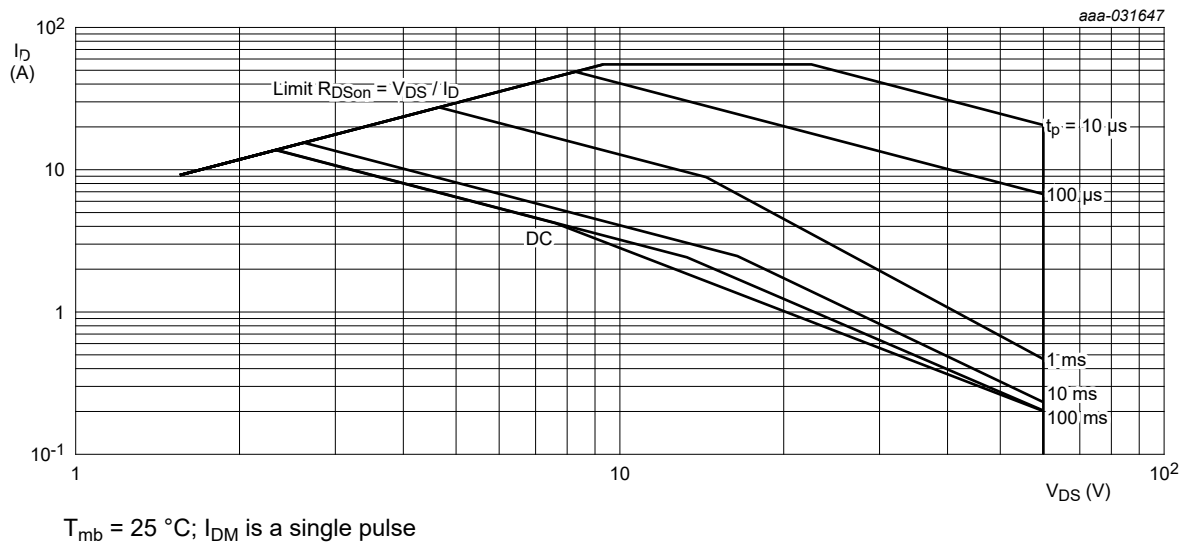


Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

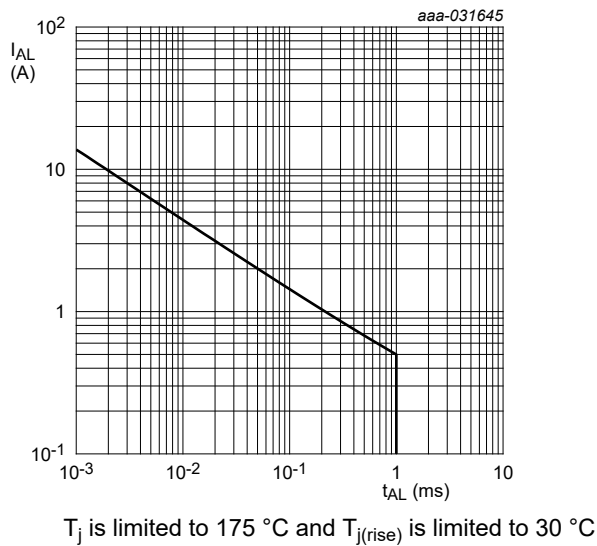


Fig. 4. Repetitive avalanche rating; avalanche current as a function of avalanche time

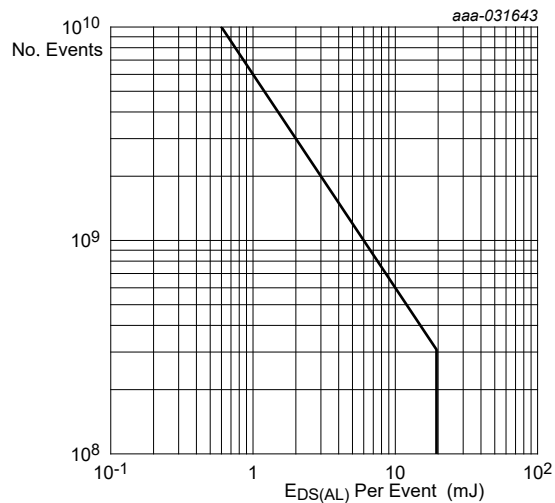


Fig. 5. Repetitive avalanche rating; maximum number of avalanche events as a function of avalanche energy

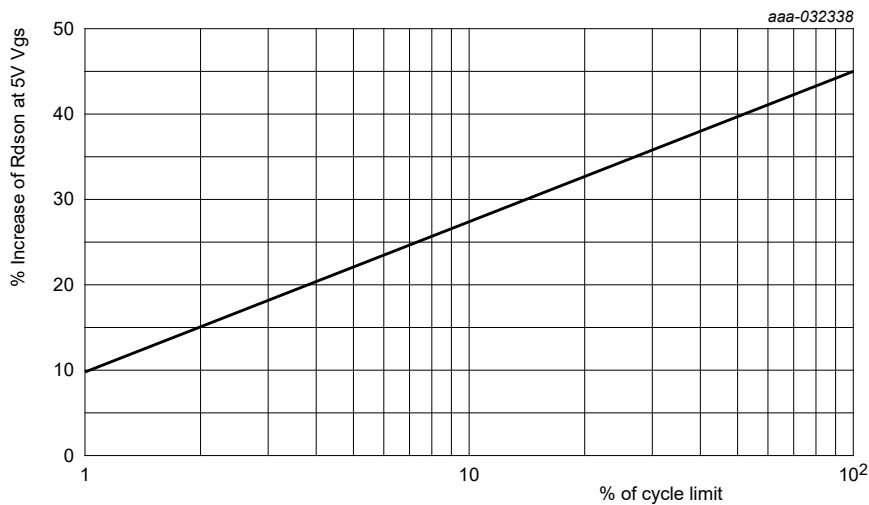
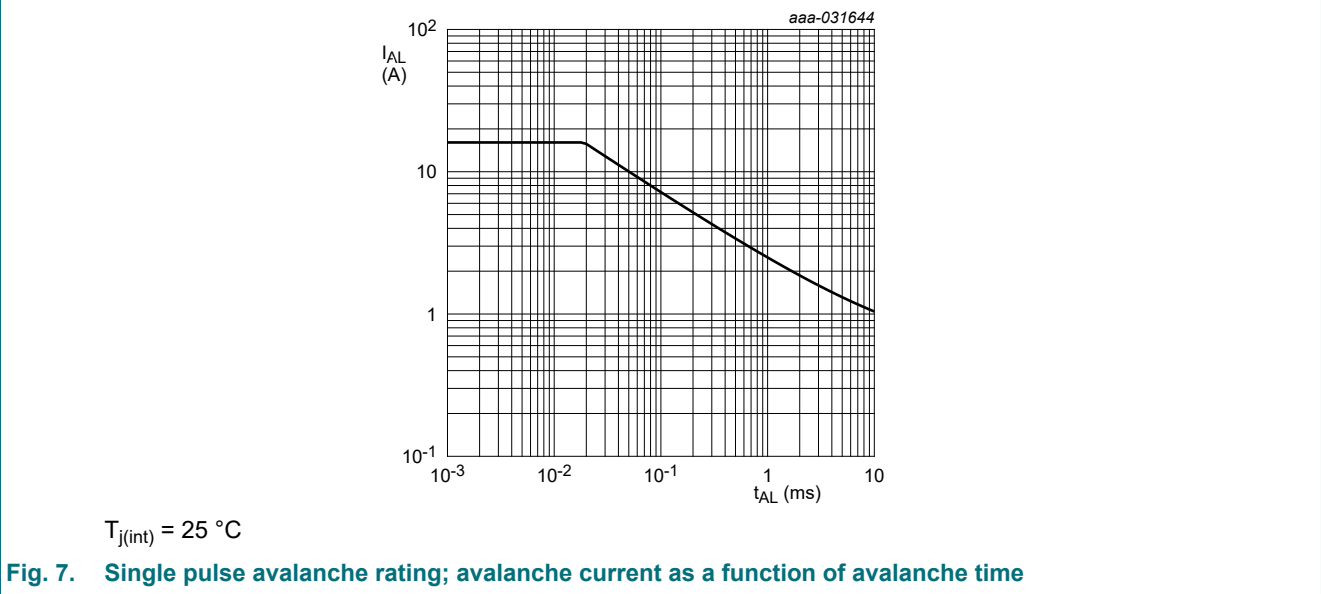


Fig. 6. Percentage  $R_{DS(on)}$  at 5V increase as a function of avalanche cycles

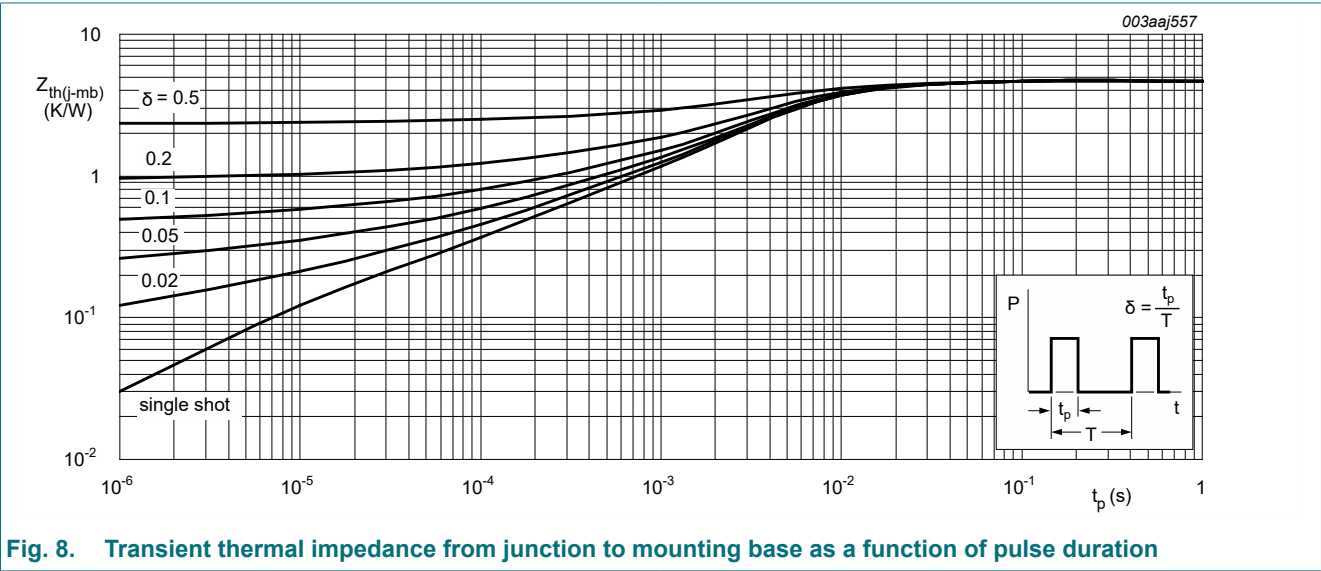
Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology



9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter                                         | Conditions                                            | Min | Typ | Max  | Unit |
|----------------|---------------------------------------------------|-------------------------------------------------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig. 8                                                | -   | -   | 4.68 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | Minimum footprint; mounted on a printed circuit board | -   | 95  | -    | K/W  |



## 10. Characteristics

Table 7. Characteristics

| Symbol                                | Parameter                        | Conditions                                                                                                                                     |  | Min  | Typ   | Max  | Unit |
|---------------------------------------|----------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------|--|------|-------|------|------|
| Static characteristics FET1 and FET2  |                                  |                                                                                                                                                |  |      |       |      |      |
| V <sub>(BR)DSS</sub>                  | drain-source breakdown voltage   | I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = -55 °C                                                                        |  | 54   | -     | -    | V    |
|                                       |                                  | I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                         |  | 60   | -     | -    | V    |
| V <sub>GS(th)</sub>                   | gate-source threshold voltage    | I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = 25 °C; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>            |  | 1.4  | 1.7   | 2.1  | V    |
|                                       |                                  | I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>           |  | 0.5  | -     | -    | V    |
|                                       |                                  | I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = -55 °C; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>           |  | -    | -     | 2.45 | V    |
| I <sub>DSS</sub>                      | drain leakage current            | V <sub>DS</sub> = 60 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                          |  | -    | 0.02  | 1    | μA   |
|                                       |                                  | V <sub>DS</sub> = 60 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C                                                                         |  | -    | -     | 500  | μA   |
| I <sub>GSS</sub>                      | gate leakage current             | V <sub>GS</sub> = -10 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                         |  | -    | 2     | 100  | nA   |
|                                       |                                  | V <sub>GS</sub> = 10 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                                                                          |  | -    | 2     | 100  | nA   |
| R <sub>DSon</sub>                     | drain-source on-state resistance | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 15</a>                                                   |  | 26.7 | 47.3  | 55   | mΩ   |
|                                       |                                  | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 175 °C; <a href="#">Fig. 15</a> ; <a href="#">Fig. 16</a>                        |  | -    | 106.9 | 124  | mΩ   |
|                                       |                                  | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 15</a>                                                  |  | 23.8 | 41.4  | 49   | mΩ   |
| Dynamic characteristics FET1 and FET2 |                                  |                                                                                                                                                |  |      |       |      |      |
| Q <sub>G(tot)</sub>                   | total gate charge                | I <sub>D</sub> = 5 A; V <sub>DS</sub> = 48 V; V <sub>GS</sub> = 5 V; T <sub>j</sub> = 25 °C; <a href="#">Fig. 17</a> ; <a href="#">Fig. 18</a> |  | -    | 5.6   | -    | nC   |
| Q <sub>GS</sub>                       | gate-source charge               |                                                                                                                                                |  | -    | 1.1   | -    | nC   |
| Q <sub>GD</sub>                       | gate-drain charge                |                                                                                                                                                |  | -    | 2.3   | -    | nC   |
| C <sub>iss</sub>                      | input capacitance                | V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz; T <sub>j</sub> = 25 °C; <a href="#">Fig. 19</a>                                      |  | -    | 544   | 725  | pF   |
| C <sub>oss</sub>                      | output capacitance               |                                                                                                                                                |  | -    | 74    | 89   | pF   |
| C <sub>rss</sub>                      | reverse transfer capacitance     |                                                                                                                                                |  | -    | 40    | 55   | pF   |
| t <sub>d(on)</sub>                    | turn-on delay time               | V <sub>DS</sub> = 48 V; R <sub>L</sub> = 10 Ω; V <sub>GS</sub> = 5 V; R <sub>G(ext)</sub> = 5 Ω; T <sub>j</sub> = 25 °C                        |  | -    | 6.2   | -    | ns   |
| t <sub>r</sub>                        | rise time                        |                                                                                                                                                |  | -    | 10.1  | -    | ns   |
| t <sub>d(off)</sub>                   | turn-off delay time              |                                                                                                                                                |  | -    | 10.7  | -    | ns   |
| t <sub>f</sub>                        | fall time                        |                                                                                                                                                |  | -    | 9     | -    | ns   |
| Source-drain diode FET1 and FET2      |                                  |                                                                                                                                                |  |      |       |      |      |
| V <sub>SD</sub>                       | source-drain voltage             | I <sub>S</sub> = 5 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; <a href="#">Fig. 20</a>                                                   |  | -    | 0.78  | 1.2  | V    |
| t <sub>rr</sub>                       | reverse recovery time            | I <sub>S</sub> = 5 A; dI <sub>S</sub> /dt = -100 A/μs; V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 30 V; T <sub>j</sub> = 25 °C                   |  | -    | 17.7  | -    | ns   |
| Q <sub>r</sub>                        | recovered charge                 |                                                                                                                                                |  | -    | 11.6  | -    | nC   |

Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

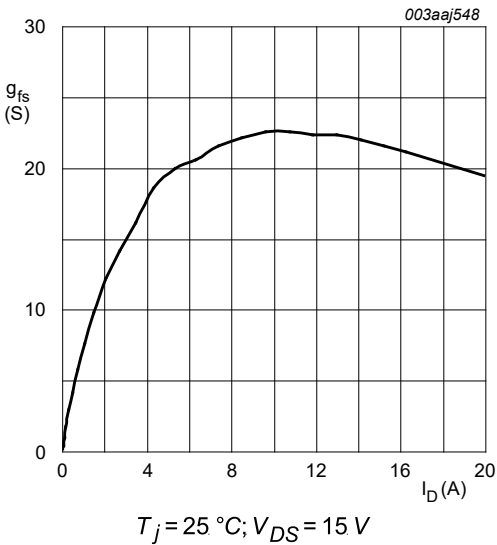


Fig. 9. Forward transconductance as a function of drain current; typical values

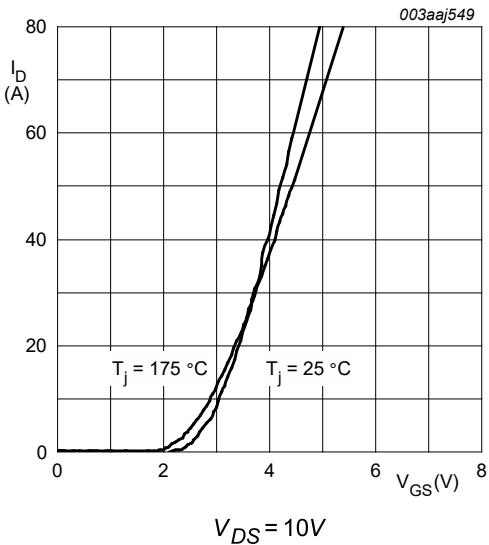


Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

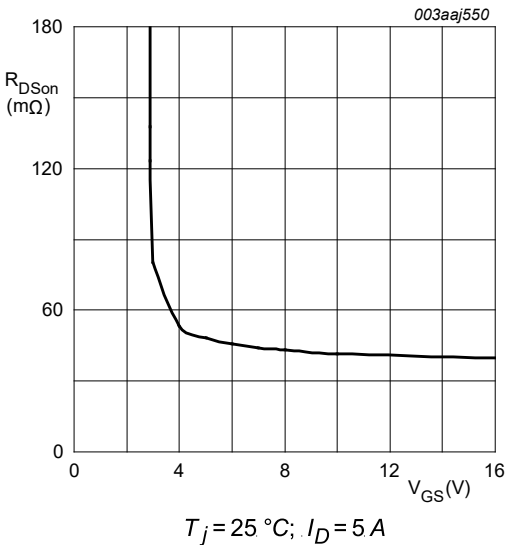


Fig. 11. Drain-source on-state resistance as a function of gate-source voltage; typical values

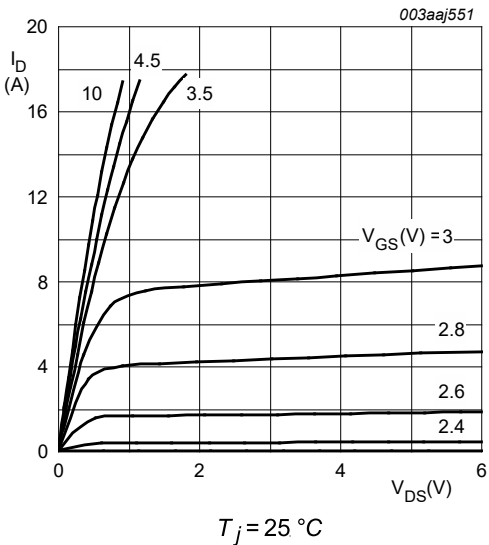


Fig. 12. Output characteristics: drain current as a function of drain-source voltage; typical values

Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

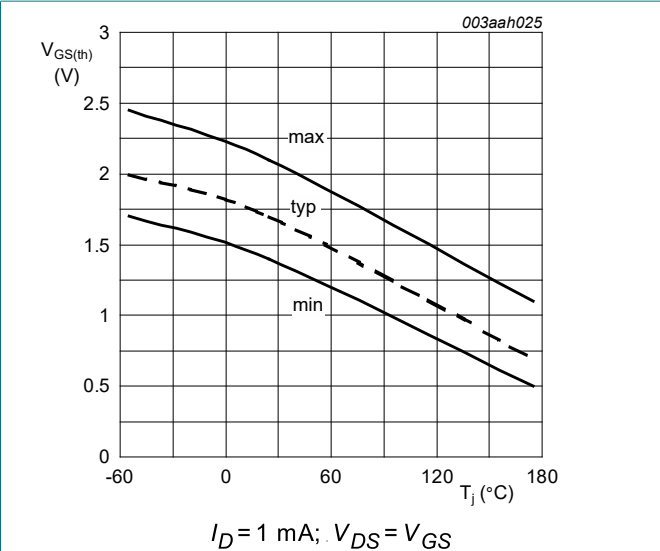


Fig. 13. Gate-source threshold voltage as a function of junction temperature

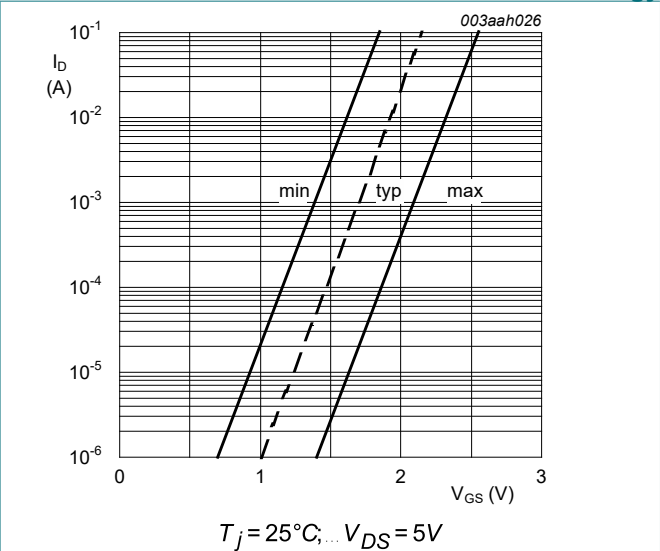


Fig. 14. Sub-threshold drain current as a function of gate-source voltage

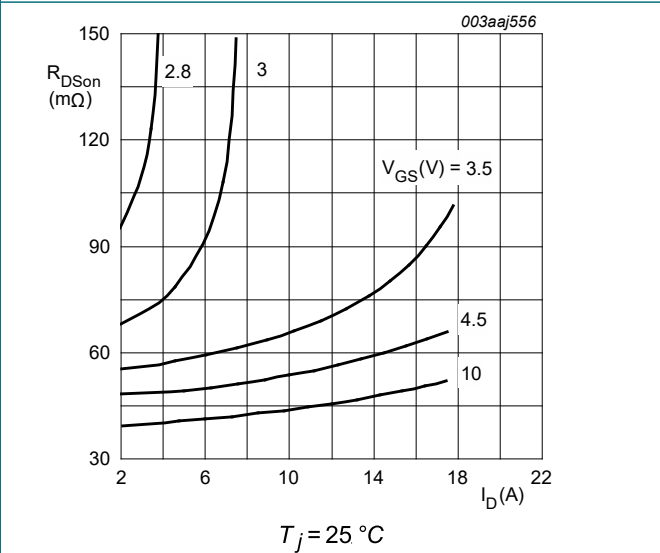


Fig. 15. Drain-source on-state resistance as a function of drain current; typical values

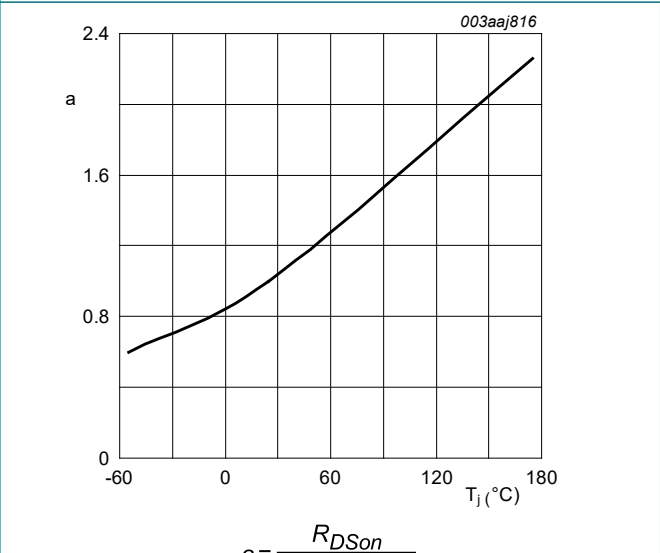


Fig. 16. Normalized drain-source on-state resistance factor as a function of junction temperature

Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

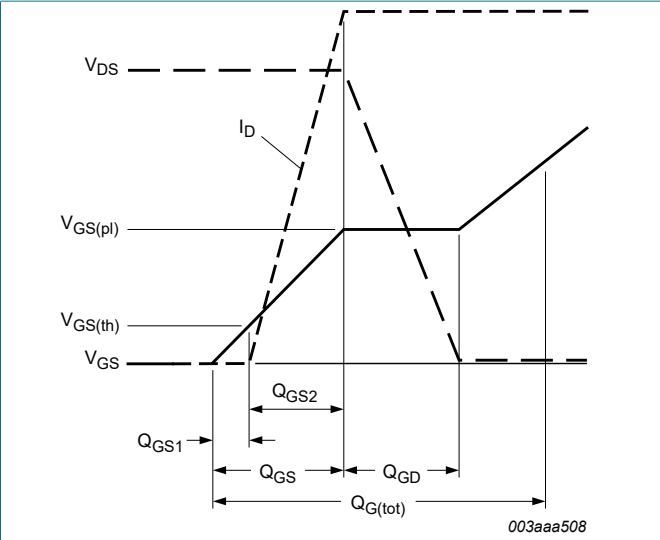


Fig. 17. Gate charge waveform definitions

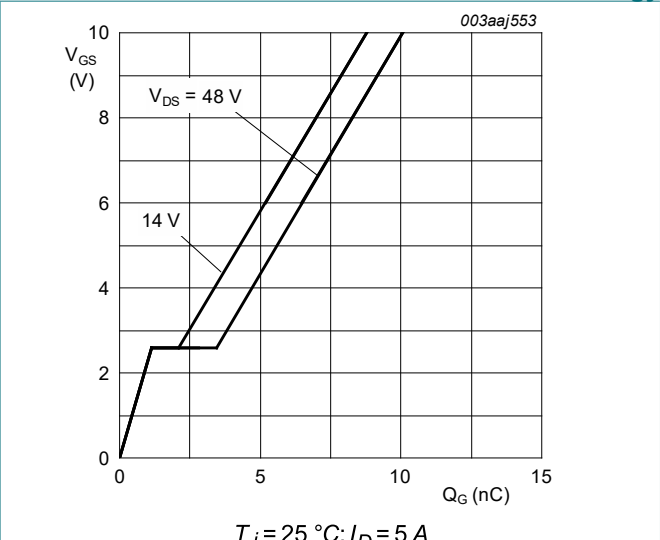


Fig. 18. Gate-source voltage as a function of gate charge; typical values

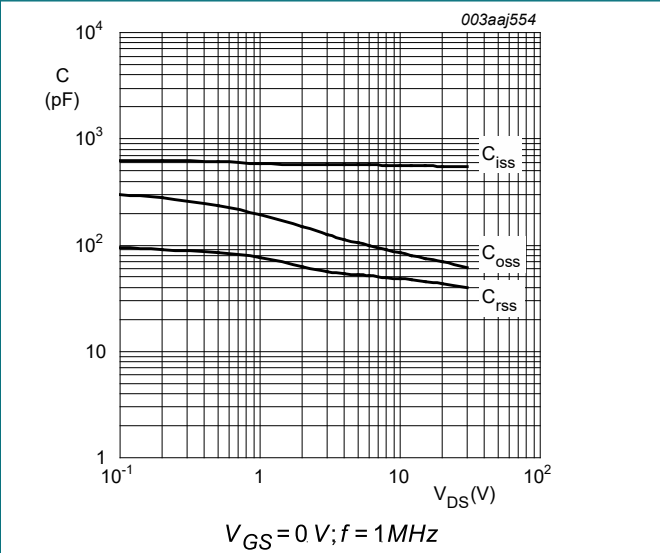


Fig. 19. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

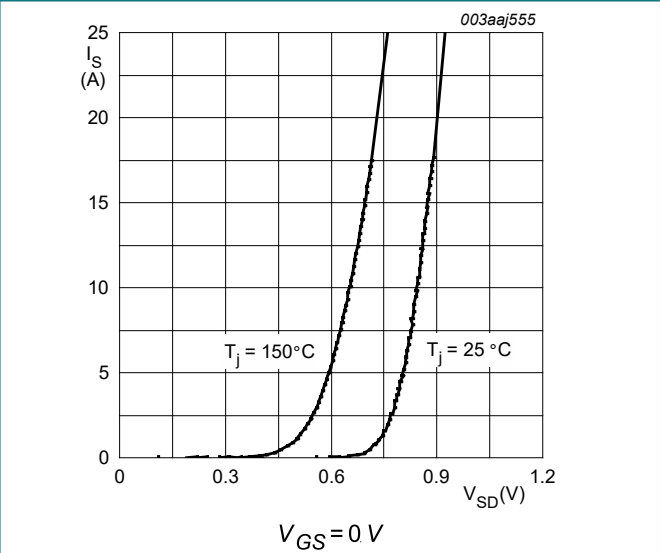


Fig. 20. Source current as a function of source-drain voltage; typical values

11. Package outline

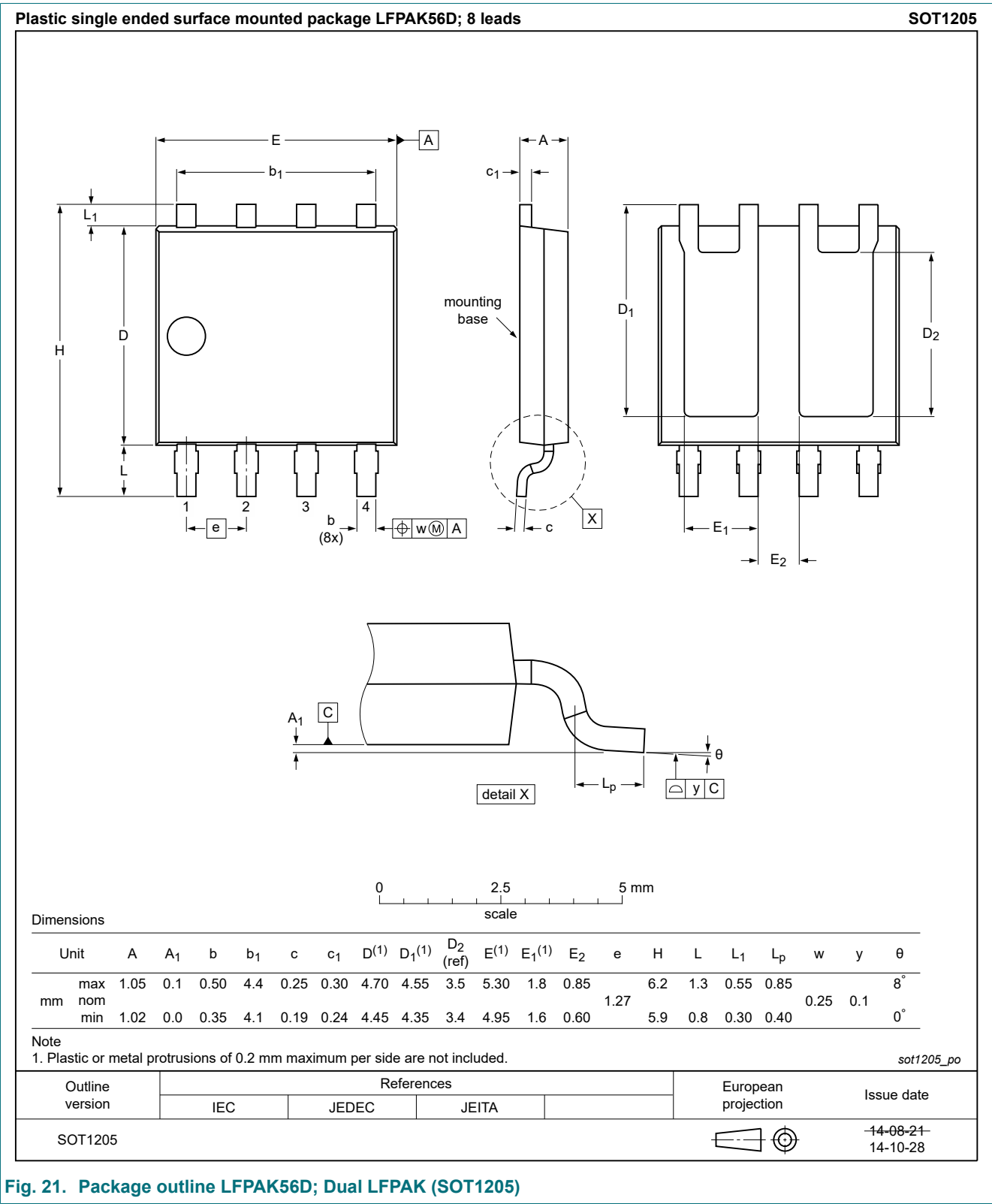


Fig. 21. Package outline LPAK56D; Dual LPAK (SOT1205)

12. Soldering

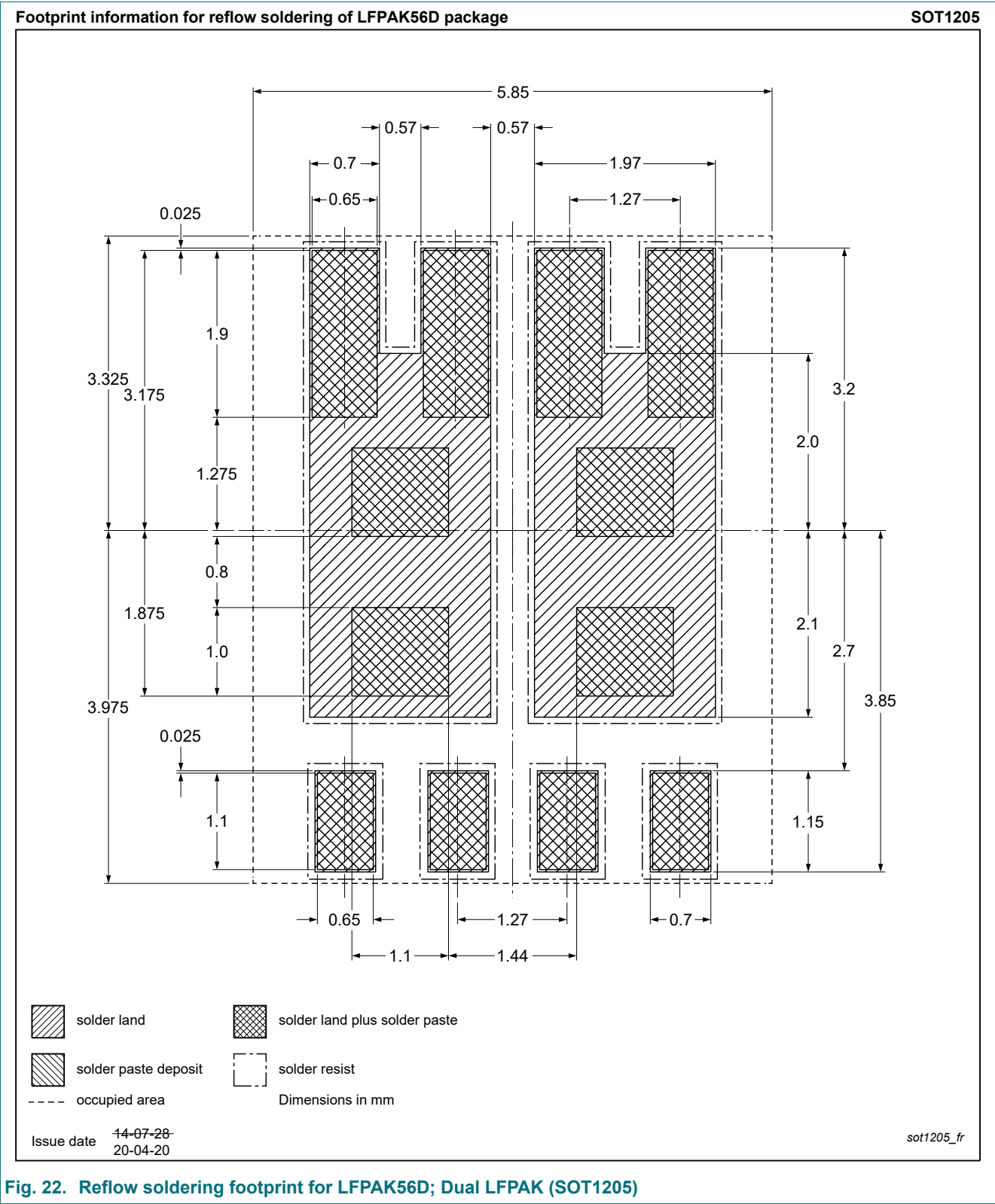


Fig. 22. Reflow soldering footprint for LPAK56D; Dual LPAK (SOT1205)

## Dual N-channel 60 V, 55 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

### 13. Legal information

#### Data sheet status

| Document status<br>[1][2]      | Product status [3] | Definition                                                                            |
|--------------------------------|--------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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